T. Lari

INFN and University of Milan

ATLAS Pixel collaboration

Test beam results on ATLAS Pixel sensors

Pixel2002

Carmel, 10/09/2002

Overview

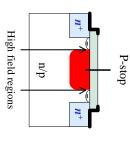
silicon sensors + DSM rad-hard electronics) have been irradiated to Pixel detectors with the ATLAS production design (oxygenated $1.1 \times 10^{15} \text{ n}_{\text{eq}} \text{ cm}^{-2} \text{and } 600 \text{ kGray}.$

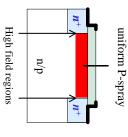
They have been tested at CERN with a 180 GeV pion beam.

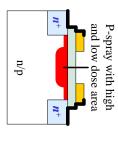
The following measurements have been performed:

- Depletion depth
- Charge collection
- Detection efficiency
- Spatial resolution

ATLAS Pixel sensors









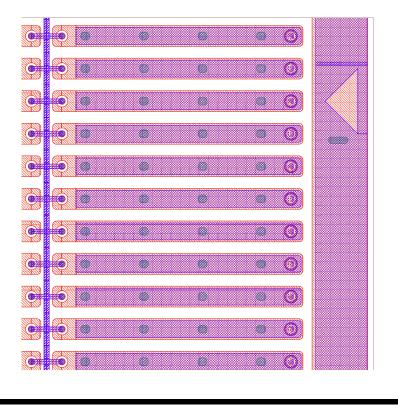
Oxygenated silicon

 $50 \times 400 \ \mu \mathrm{m}^2 \mathrm{pixels}$

250 μm thickness

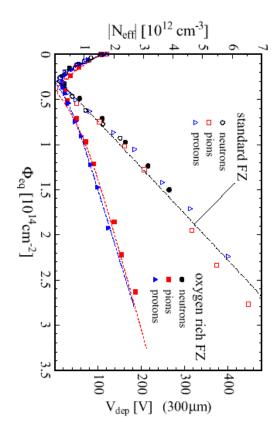
 $8 \times 8 \text{ mm}^2$ (single chip) or

 $16 \times 64 \text{ mm}^2 \text{ (module) size}$



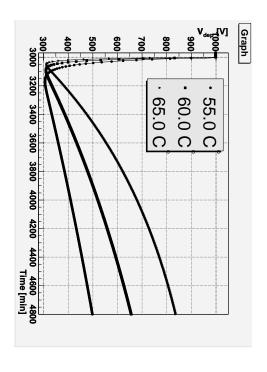
Irradiation

Several single chip assemblies with oxygenated silicon have been irradiated to $1.1 \times 10^{15} \ \mathrm{n_{eq} \ cm^{-2}}$ and 600 kGray.



ROSE collaboration

NIM A466, 308

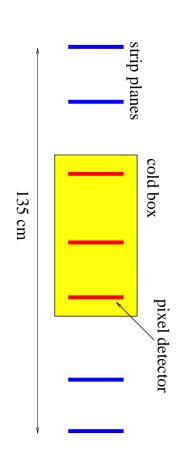


O. Krasel

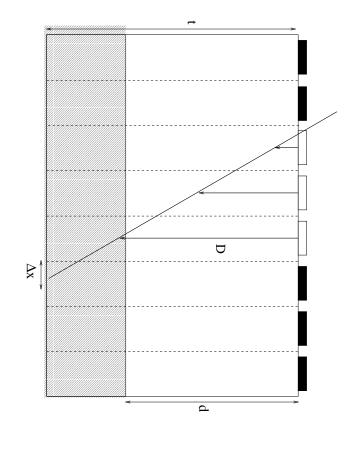
Testbeam setup

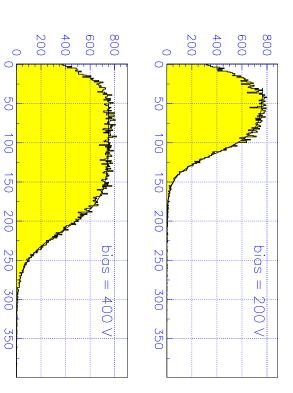
resolution of $\sim 6~\mu\mathrm{m}$ at the pixel detector planes. 4 planes of double-sided microstrip planes track the particles with a

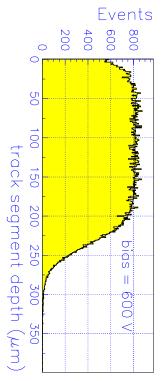
Pixel detectors are inside a cold box.



Measurement of depletion depth



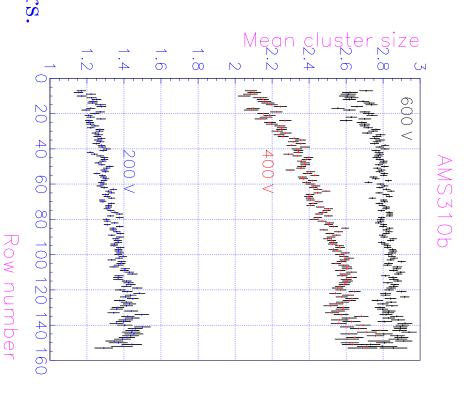




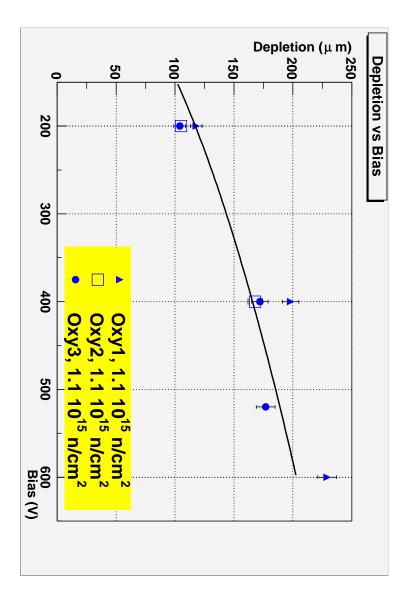
Not uniform irradiation

$220 \pm 6 \pm 7$	110-151
$206 \pm 3 \pm 7$	80-109
$189 \pm 4 \pm 6$	50-79
$175 \pm 4 \pm 6$	7-49
depletion	rows

Leakage current decreases with row number. The same behaviour is observed for all the irradiated detectors.

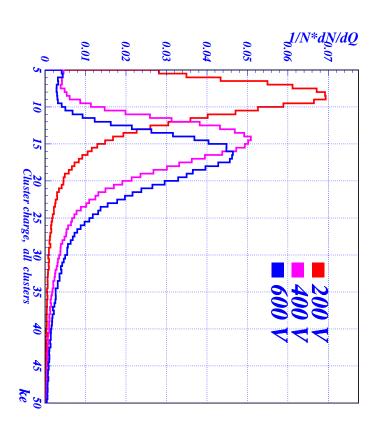


Summary of depletion measurements



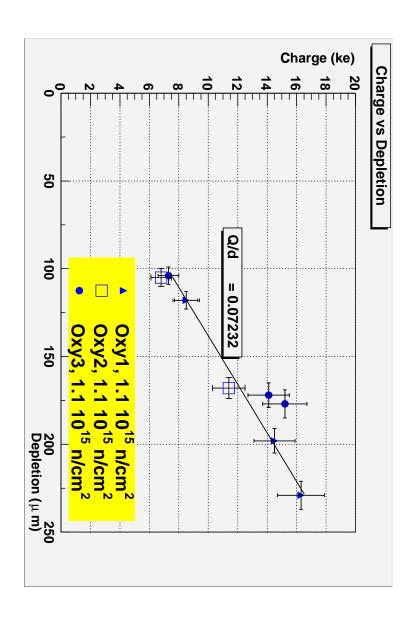
Pulse height

The accuracy of the calibrations is about 10% The charge is measured using the time over threshold of the signal.

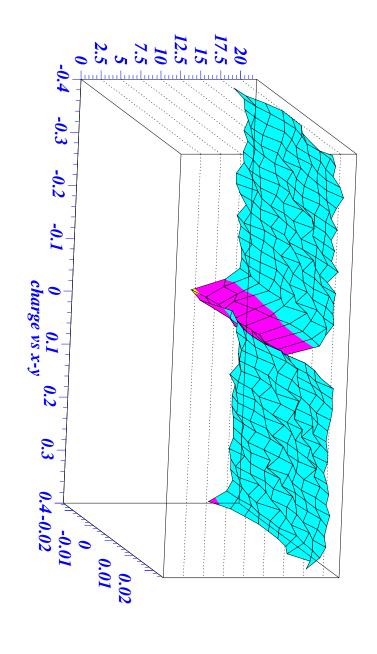


Pulse height vs depletion

scales as the depletion The most probable pulse height measured at 0 degree incidence angle



Charge collection uniformity



cells Charge collection as a function of track position inside a pair of pixel

Efficiency

the particle (from a scintillator) and the clock edge Efficiency as a function of the difference between the arrival time of

$$\epsilon=98.2~\%$$

$$\tau = 1.75 \text{ ns}$$

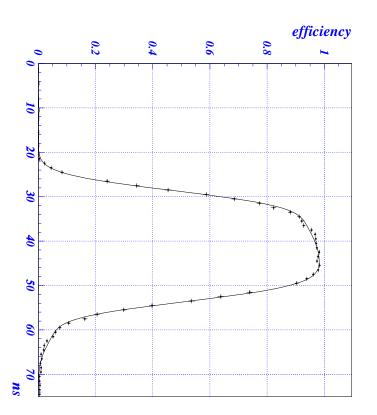
$$\sigma = 4.34 \text{ ns}$$

Fitting function:

$$\epsilon - e^{-(t-t_0)/\tau}$$
 [t₀, t₀ + 25]

 $[0,t_0]$

$$e - e^{-(t-t_0-25)/\tau} - [t_0, t_0 + 25]$$
 $e^{-(t-t_0-25)/\tau} - e^{-(t-t_0)/\tau} [t_0 + 25, 75]$

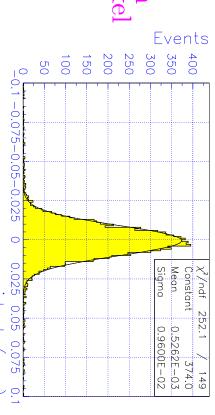


Spatial residuals

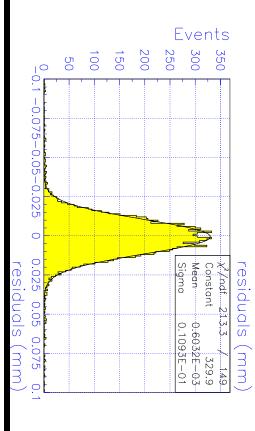
Irradiated detector at 10 degrees incidence angle

AMS310b 600 V, 10 degrees

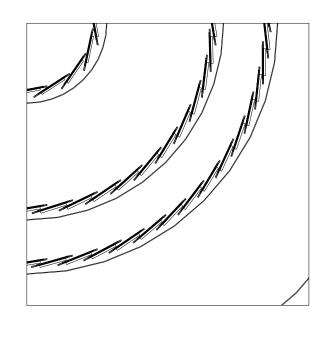
Residuals with charge interpolation for clusters with more than one pixel $\sigma=9.6~\mu\mathrm{m}$



Digital residuals $\sigma = 10.9 \ \mu \mathrm{m}$

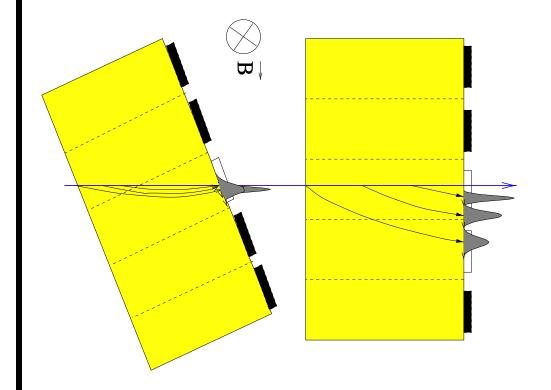


Effective incidence angle in ATLAS



tilt angle = 20 degrees

Lorentz angle = 5 degrees at 600 V, full depletion



Conclusions

irradiated to the design fluence and operated at the test beam ATLAS Pixel detectors with oxygenated silicon sensors have been

resolution required in ATLAS. expectations and allowed to obtain the efficiency and spatial The depletion depth and charge collected were consistent with

The depletion depth at 600 V is $229 \pm 8~\mu\mathrm{m}$

The detection efficiency is 98.2%

The spatial resolution at 10 degrees is 9.6 μ m